



EF3DV3 - SN:4060

May 29, 2020

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	0.79	0.74	1.28	± 10.1 %
DCP (mV) ^B	95.3	97.8	96.5	

Calibration results for Frequency Response (30 MHz - 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.2	77.3	0.1%	77.3	0.1%	± 5.1 %
100	77.3	78.2	1.2%	78.5	1.5%	± 5.1 %
450	77.1	78.1	1.2%	78.2	1.4%	± 5.1 %
600	77.2	77.7	0.6%	77.7	0.7%	± 5.1 %
750	77.3	77.4	0.3%	77.4	0.3%	± 5.1 %
1800	140.3	138.3	-2.8%	139.2	-2.1%	± 5.1 %
2000	133.0	131.4	-2.7%	131.4	-2.7%	± 5.1 %
2200	125.1	123.5	-3.3%	124.5	-2.5%	± 5.1 %
2500	123.7	122.4	-2.5%	123.2	-1.8%	± 5.1 %
3000	78.9	75.8	-4.6%	76.7	-3.4%	± 5.1 %
3500	250.5	247.6	-3.3%	243.6	-4.8%	± 5.1 %
3700	244.2	239.8	-3.9%	237.6	-4.8%	± 5.1 %
5200	50.8	51.3	1.1%	51.7	1.8%	± 5.1 %
5500	49.7	49.4	-0.6%	48.2	-3.1%	± 5.1 %
5800	48.9	48.6	-0.6%	49.7	1.7%	± 5.1 %

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: EF3-4060_May20

Page 3 of 21

⁸ Numerical linearization parameter: uncertainty not required.
^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.





May 29, 2020 EF3DV3 - SN:4060

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Max dev.	Max Unc ^E (k=2)
0	CW	X	0.00	0.00	1.00	0.00	125.9	± 3.5 %	± 4.7 %
		Y	0.00	0.00	1.00		166.9]	
		Z	0.00	0.00	1.00		128.4		
10352-	Pulse Waveform (200Hz, 10%)	X	2.22	64.12	8.85	10.00	60.0	± 2.9 %	± 9.6 %
AAA	# CONTROL OF THE CONT	Y	3.72	69.58	11.72		60.0		
		Z	2.68	66.15	10.03		60.0		
10353-	Pulse Waveform (200Hz, 20%)	X	1.05	61.61	6.69	6.99	80.0	± 1.0 %	± 9.6 %
AAA		Y	2.73	69.71	10.89		80.0		
		Z	1.39	64.06	8.17		80.0		
10354-	Pulse Waveform (200Hz, 40%)	X	0.64	61.95	5.93	3.98	95.0	± 0.8 %	± 9.6 %
AAA	The components of the decay will define a section of the control o	Y	20.00	88.10	15.51		95.0		
		Z	1.00	65.44	7.85		95.0		
10355- Pulse	Pulse Waveform (200Hz, 60%)	X	0.66	64.74	6.65	2.22	120.0	± 1.0 %	± 9.6 %
AAA		Y	20.00	93.78	17.20		120.0		
		Z	20.00	84.41	12.55		120.0		
10387-	QPSK Waveform, 1 MHz	X	1.98	70.59	17.17	1.00	150.0	± 1.9 %	± 9.6 %
AAA		Y	1.94	69.99	16.92		150.0		
		Z	2.02	71.47	17.51		150.0		
10388-	QPSK Waveform, 10 MHz	X	2.54	70.83	17.55	0.00	150.0	± 1.1 %	± 9.6 %
AAA		Y	2.51	70.47	17.33		150.0		
		Z	2.43	70.41	17.43		150.0		
10396-	64-QAM Waveform, 100 kHz	X	2.34	69.66	19.06	3.01	150.0	± 1.1 %	± 9.6 %
AAA	Company of the second control of the second	Y	2.49	70.33	19.41		150.0		
		Z	2.09	67.16	17.82		150.0		
10399-	64-QAM Waveform, 40 MHz	X	3.51	67.32	16.24	0.00	150.0	± 1.0 %	± 9.6 %
AAA	- networks where we define a set to the set of the set	Y	3.62	67.78	16.40		150.0		
		Z	3.52	67.45	16.34		150.0		
10414-	WLAN CCDF, 64-QAM, 40MHz	X	4.74	65.60	15.79	0.00	150.0	± 2.0 %	± 9.6 %
AAA		Y	4.72	65.49	15.68		150.0		
general constant		Z	4.73	65.70	15.88		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: EF3-4060_May20

Page 4 of 21

B Numerical linearization parameter: uncertainty not required. E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the





DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.20	0.19	4.60
Frequency Corr. (HF)	2.82	2.82	2.82

Sensor Model Parameters

	C1 fF	C2 fF	α V ⁻¹	T1 ms.V ⁻²	T2 ms.V ⁻¹	T3 ms	T4 V ⁻²	T5 V ⁻¹	Т6
X	39.4	262.85	37.46	5.11	0.07	4.93	0.89	0.00	1.00
Υ	40.3	265.26	36.67	6.10	0.00	4.98	1.07	0.00	1.00
Z	37.4	250.57	37.84	4.63	0.03	4.97	0.00	0.14	1.00

Other Probe Parameters

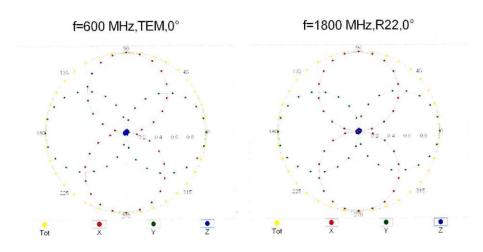
Sensor Arrangement	Rectangular
Connector Angle (°)	-35
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

Certificate No: EF3-4060_May20

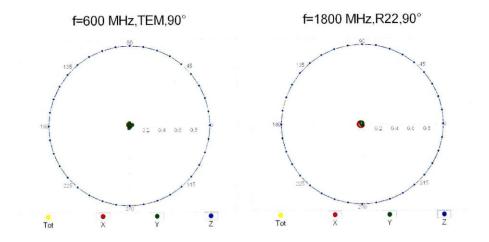
Page 5 of 21



Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



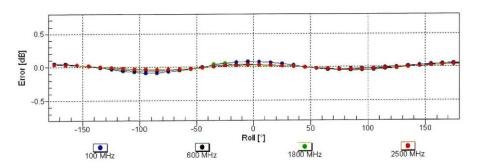
Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



Certificate No: EF3-4060_May20 Page 6 of 21

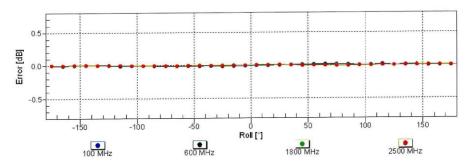


Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $9 = 90^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

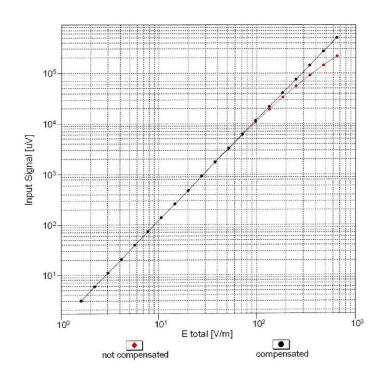
Certificate No: EF3-4060_May20

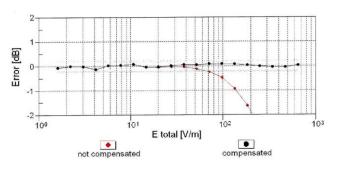
Page 7 of 21





Dynamic Range f(E-field) (TEM cell, f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: EF3-4060_May20

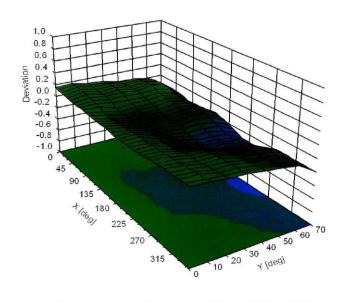
Page 8 of 21

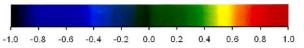


EF3DV3 - SN:4060

May 29, 2020

Deviation from Isotropy in Air Error (ϕ , ϑ), f = 900 MHz





Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: EF3-4060_May20

Page 9 of 21





ANNEX E DIPOLE CALIBRATION CERTIFICATE

Dipole 835 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client

CTTL-B.I (Auden)

Certificate No: CD835V3-1023 Aug20

ient CTTL-BJ (Auden			cate No: CD835V3-1023_Aug2
CALIBRATION C	ERTIFICATI		
Object	CD835V3 - SN: 1	1023	
Calibration procedure(s)	QA CAL-20.v7 Calibration Proce	edure for Validation Source	s in air
Calibration date:	August 18, 2020		
The measurements and the uncertable measurements and the uncertable measurements and the uncertable measurements.	ainties with confidence p	onal standards, which realize the phy robability are given on the following p ry facility: environment temperature (2	ages and are part of the certificate.
Calibration Equipment used (M&TE Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
ower sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
eference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
ype-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	31-Dec-19 (No. EF3-4013 Dec19)	
DAE4	SN: 781	27-Dec-19 (No. DAE4-781_Dec19	
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17) In house check: Oct-20
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17) In house check: Oct-20
ower sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)) In house check: Oct-20
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Jan-19) In house check: Oct-20
etwork Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-19	In house check: Oct-20
	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	Sef My
Approved by:	Katja Pokovic	Technical Manager	Muc
Calibrated by: Approved by:			Sef Iller

Certificate No: CD835V3-1023_Aug20

Page 1 of 5